











REF3112, REF3120, REF3125 REF3130, REF3133, REF3140

SBVS046D - DECEMBER 2003-REVISED MARCH 2016

REF31xx 15ppm/°C Maximum, 100-μA, SOT-23 Series Voltage Reference

Features

MicroSize Package: SOT23-3

Low Dropout: 5 mV

High Output Current: ±10 mA High Accuracy: 0.2% Maximum

Low Io: 115 µA Maximum

Excellent Specified Drift Performance:

15 ppm/°C (Maximum) from 0°C to +70°C

20 ppm/°C (Maximum) from –40°C to +125°C

Applications

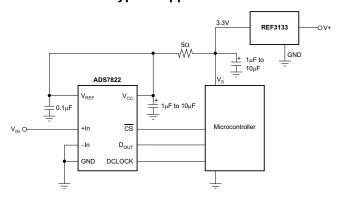
Portable, Battery-Powered Equipment

Data Acquisition Systems

Medical Equipment

Hand-Held Test Equipment

Typical Application



3 Description

The REF31xx is a family of precision, low power, low dropout, series voltage references available in the tiny 3-pin SOT-23 package.

The REF31xx's small size and consumption (100 µA typical) make it ideal for portable and battery-powered applications. The REF31xx does not require a load capacitor, but is stable with any capacitive load and can sink or source up to 10 mA of output current.

Unloaded, the REF31xx can operate on supplies down to 5 mV above the output voltage. All models are specified for the wide temperature range of -40°C to +125°C.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)	
REF31xx	SOT-23 (3)	2.92 mm × 1.30 mm	

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Dropout Voltage vs Load Current

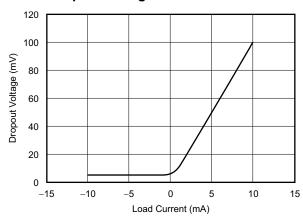




Table of Contents

1	Features 1		8.4 Device Functional Modes	13
2	Applications 1	9	Application and Implementation	15
3	Description 1		9.1 Application Information	
4	Revision History2		9.2 Typical Application	15
5	Device Comparison Table 3	10	Power Supply Recommendations	17
6	Pin Configuration and Functions	11	Layout	17
7	Specifications4		11.1 Layout Guidelines	17
•	7.1 Absolute Maximum Ratings4		11.2 Layout Example	17
	7.2 ESD Ratings	12	Device and Documentation Support	18
	7.3 Recommended Operating Conditions		12.1 Device Support	18
	7.4 Thermal Information		12.2 Related Links	18
	7.5 Electrical Characteristics		12.3 Community Resources	18
	7.6 Typical Characteristics 6		12.4 Trademarks	18
8	Detailed Description 10		12.5 Electrostatic Discharge Caution	18
-	8.1 Overview		12.6 Glossary	18
	8.2 Functional Block Diagram 10	13	Mechanical, Packaging, and Orderable Information	18
	8.3 Feature Description			

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (February 2006) to Revision D

Page

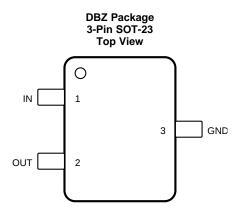
•	Added the Device Information table, the Thermal Information table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section.	. 1
•	Removed the Ordering Information table	. 1
•	Moved and updated the SOT23-3 surface mount thermal resistance data from the <i>Electrical Characteristics</i> table to the <i>Thermal Information</i> table	. 4
•	Removed the boldface type in the <i>Electrical Characteristics</i> table and identified when limits apply over the specified temperature range $T_A = -40$ °C to +125°C in the test conditions column	. 4
•	Added Figure 19	8



5 Device Comparison Table

PRODUCT	VOLTAGE (V)
REF3112	1.25
REF3120	2.048
REF3125	2.5
REF3130	3
REF3133	3.3
REF3140	4.096

6 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION	
NO.	NAME	1/0	DESCRIPTION	
1	IN	I	Input supply voltage	
2	OUT	0	Reference output voltage	
3	GND	_	Ground	



7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

	MIN	MAX	UNIT
Supply voltage, V+ to V-		7	V
Output short circuit	Continuous		
Operating temperature	-55	135	°C
Junction temperature		150	°C
Storage temperature, T _{stg}	-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

			VALUE	UNIT
\ /	Electrostatic	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	\ <u>/</u>
V _(ESD)	discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
V_{IN}	Input voltage	V _{REF} + 0.05 ⁽¹⁾	5.5	V
I _{LOAD}	Load current		25	mA
T _A	Operating temperature	-40	125	°C

⁽¹⁾ Minimum supply voltage for the REF3112 is 1.8 V.

7.4 Thermal Information

		REF31xx	
	THERMAL METRIC ⁽¹⁾	DBZ (SOT-23)	UNIT
		3 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	292.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	124.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	89	°C/W
ΨЈТ	Junction-to-top characterization parameter	11.4	°C/W
ΨЈВ	Junction-to-board characterization parameter	87.6	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	_	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

7.5 Electrical Characteristics

at $T_A = 25$ °C, $I_{LOAD} = 0$ mA, and $V_{IN} = 5$ V (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
REF3312 ⁽¹⁾ -	- 1.25 V					
.,	Output voltage		1.2475	1.25	1.2525	V
V _{OUT}	Initial accuracy		-0.2%		0.2%	
Output voltage noise		f = 0.1 Hz to 10 Hz		17		μV_{PP}
		f = 10 Hz to 10 kHz		24		μV_{RMS}

(1) Minimum supply voltage for the REF3112 is 1.8 V.



Electrical Characteristics (continued)

at $T_A = 25$ °C, $I_{LOAD} = 0$ mA, and $V_{IN} = 5$ V (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
REF3120 — 2	.048 V						
.,	Output voltage			2.0439	2.048	2.0521	V
V _{OUT}	Initial accuracy			-0.2%		0.2%	
			f = 0.1Hz to 10Hz		27		μV _{PP}
	Output voltage noise		f = 10Hz to 10kHz		39		μV _{RMS}
REF3125 — 2	.5 V			1			
	Output voltage			2.495	2.5	2.505	V
V _{OUT}	Initial accuracy			-0.2%		0.2%	
			f = 0.1Hz to 10Hz		33		μV_{PP}
	Output voltage noise		f = 10Hz to 10kHz		48		μV_{RMS}
REF3130 — 3	V			1			
	Output voltage			2.994	3	3.006	V
V _{OUT}	Initial accuracy			-0.2%		0.2%	
			f = 0.1Hz to 10Hz		39		μV _{PP}
	Output voltage noise		f = 10Hz to 10kHz		57		μV _{RMS}
REF3133 — 3	.3 V		1	1			
	Output voltage			3.2934	3.3	3.3066	V
V _{OUT}	Initial accuracy			-0.2%		0.2%	
	Output voltage noise		f = 0.1Hz to 10Hz		43		μV_{PP}
			f = 10Hz to 10kHz		63		μV _{RMS}
REF3140 — 4	.096 V						1 Itimo
	Output voltage			4.0878	4.096	4.1042	V
V _{OUT}	Initial accuracy			-0.2%		0.2%	
	-		f = 0.1Hz to 10Hz		53		μV_{PP}
	Output voltage noise		f = 10Hz to 10kHz		78		μV _{RMS}
REF31xx (RE	F3112, REF3120, REF	3125, REF3130, REF	3133, REF3140)				
<u> </u>			$T_A = 0$ °C to 70°C.		5	15	
dV _{OUT} /dT	Output voltage temper	erature drift ⁽²⁾	$T_A = -40$ °C to +125°C.		10	20	ppm/°C
	Long-term stability		0 to 1000 hours		70		ppm
	Line regulation		$V_{REF} + 0.05^{(1)} \le V_{IN} \le 5.5V$		20	65	ppm/V
		Sourcing	$0mA < I_{LOAD} < 10mA, V_{IN} = V_{REF} + 250mV^{(1)}$		10	30	
dV _{OUT} /dI _{LOAD}	Load regulation (3)	Sinking	$-10\text{mA} < I_{\text{LOAD}} < 0\text{mA}, V_{\text{IN}} = V_{\text{REF}} + 100\text{mV}^{(1)}$		20	50	μV/mA
	Thermal	First Cycle	EO/O 7 IN REI		100		
dT	hysteresis (4)	Additional Cycles			25		ppm
V _{IN} – V _{OUT}	Dropout voltage ⁽¹⁾		$T_A = -40$ °C to +125°C.		5	50	mV
I _{LOAD}	Output current		,	-10		10	mA
LOND		Sourcing			50		
I _{SC}	Short-circuit current	Sinking			40		mA
	Turnon settling time	+	To 0.1% at $V_{IN} = +5V$ with $C_L = 0\mu F$		400		μs
			115 T.	1			r
POWER SUPI							
			$I_{LOAD} = 0$, $T_A = -40^{\circ}$ C to +125°C.	$V_{REF} + 0.05^{(1)}$		5.5	V
POWER SUPI	Voltage Quiescent current		$I_{LOAD} = 0$, $T_A = -40$ °C to +125°C. $I_{LOAD} = 0$, $T_A = 25$ °C	V _{REF} + 0.05 ⁽¹⁾	100	5.5 115	V μA

⁽²⁾ Box Method used to determine temperature drift.

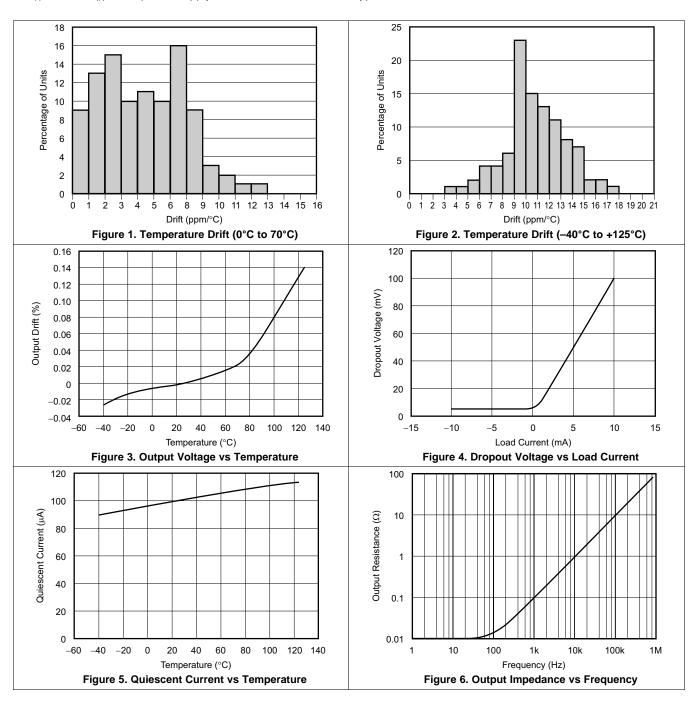
⁽³⁾ Typical value of load regulation reflects measurements using force and sense contacts; see Load Regulation.

⁽⁴⁾ Thermal hysteresis is explained in more detail in *Application and Implementation* of this data sheet.



7.6 Typical Characteristics

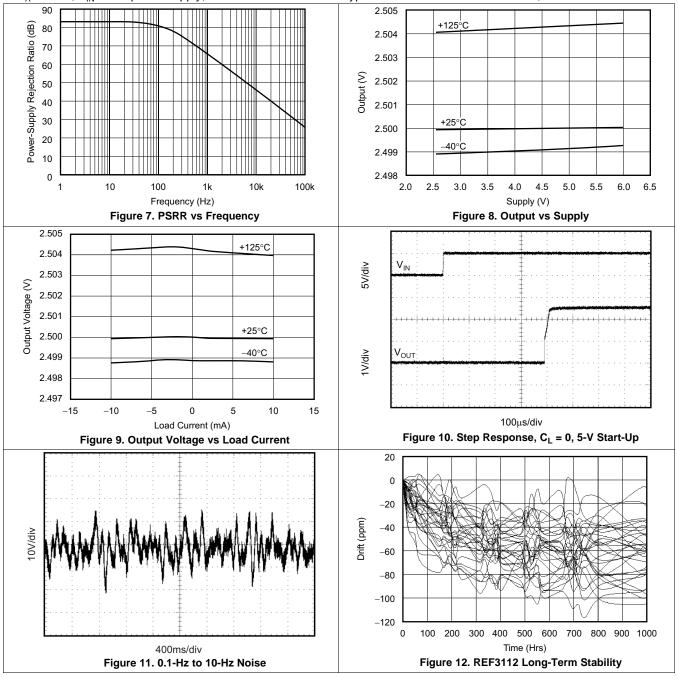
At $T_A = 25$ °C, $V_{IN} = 5$ -V power supply, and REF3125 is used for typical characteristic measurements, unless otherwise noted.





Typical Characteristics (continued)

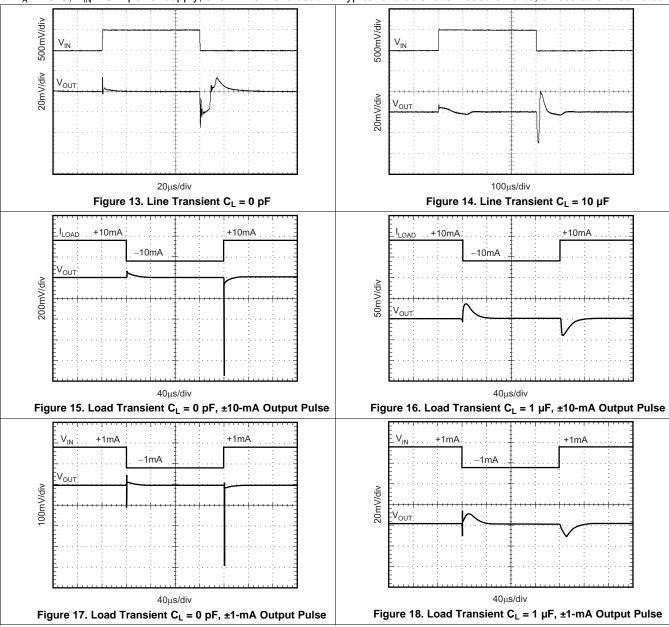
At $T_A = 25$ °C, $V_{IN} = 5$ -V power supply, and REF3125 is used for typical characteristic measurements, unless otherwise noted.





Typical Characteristics (continued)

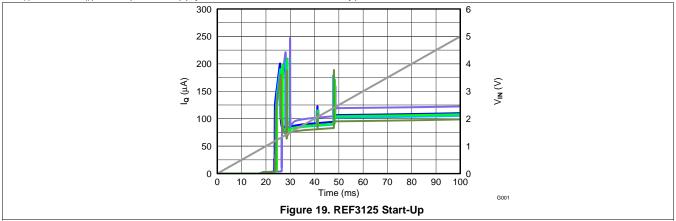
At T_A = 25°C, V_{IN} = 5-V power supply, and REF3125 is used for typical characteristic measurements, unless otherwise noted.





Typical Characteristics (continued)

At $T_A = 25$ °C, $V_{IN} = 5$ -V power supply, and REF3125 is used for typical characteristic measurements, unless otherwise noted.



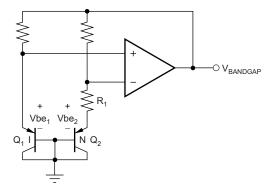


8 Detailed Description

8.1 Overview

The REF31xx is a family of series, CMOS, precision bandgap voltage references. The basic bandgap topology is shown in *Functional Block Diagram*. Transistors Q_1 and Q_2 are biased such that the current density of Q_1 is greater than that of Q_2 . The difference of the two base-emitter voltages, $Vbe_1 - Vbe_2$, has a positive temperature coefficient and is forced across resistor R_1 . This voltage is gained up and added to the base-emitter voltage of Q_2 , which has a negative temperature coefficient. The resulting output voltage is virtually independent of temperature. The curvature of the bandgap voltage, as shown in Figure 3, is due to the slightly nonlinear temperature coefficient of the base-emitter voltage of Q_2 .

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Supply Voltage

The REF31xx family of references features an extremely low dropout voltage. With the exception of the REF3112, which has a minimum supply requirement of 1.8 V, these references can be operated with a supply of only 5 mV above the output voltage in an unloaded condition. For loaded conditions, a typical dropout voltage versus load is shown in *Typical Characteristics*.

The REF31xx features a low quiescent current, which is extremely stable over changes in both temperature and supply. The typical room temperature quiescent current is 100 μ A, and the maximum quiescent current over temperature is just 135 μ A. The quiescent current typically changes less than 2 μ A over the entire supply range, as shown in Figure 20.

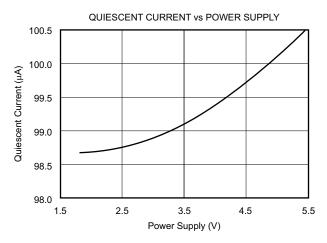


Figure 20. Supply Current vs Supply Voltage



Feature Description (continued)

Supply voltages below the specified levels can cause the REF31xx to momentarily draw currents greater than the typical quiescent current. This can be prevented by using a power supply with a fast rising edge and low output impedance.

8.3.2 Thermal Hysteresis

Thermal hysteresis for the REF31xx is defined as the change in output voltage after operating the device at 25°C, cycling the device through the specified temperature range, and returning to 25°C. It can be expressed as:

$$V_{HYST} = \left(\frac{abs|V_{PRE} - V_{POST}|}{V_{NOM}}\right) \bullet 10^{6} (ppm)$$

Where:

 V_{HYST} = Thermal hysteresis.

V_{PRE} = Output voltage measured at 25°C pretemperature cycling.

 V_{POST} = Output voltage measured after the device has been cycled through the specified temperature range of –40°C to +125°C and returned to +25°C. (1)

8.3.3 Temperature Drift

The REF31xx is designed to exhibit minimal drift error, defined as the change in output voltage over varying temperature. The drift is calculated using the *box* method, which is described in Equation 2:

$$Drift = \left(\frac{V_{OUTMAX} - V_{OUTMIN}}{V_{OUT} \cdot Temperature Range}\right) \cdot 10^6 \text{ (ppm)}$$
(2)

The REF31xx features a typical drift coefficient of 5 ppm from 0°C to 70°C, the primary temperature range for many applications. For the industrial temperature range of –40°C to +125°C, the REF31xx family drift increases to a typical value of 10 ppm.

8.3.4 Noise Performance

Typical 0.1-Hz to 10-Hz voltage noise can be seen in Figure 21. The noise voltage of the REF31xx increases with output voltage and operating temperature. Additional filtering may be used to improve output noise levels, although take care to ensure the output impedance does not degrade the AC performance.

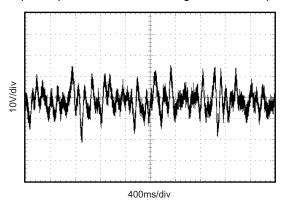


Figure 21. 0.1-Hz to 10-Hz Noise

Feature Description (continued)

8.3.5 Long-Term Stability

Long-term stability refers to the change of the output voltage of a reference over a period of months or years. This effect lessens as time progresses, as is shown by the long-term stability curves. The typical drift value for the REF31xx is 70 ppm from 0 to 1000 hours. This parameter is characterized by measuring 30 units at regular intervals for a period of 1000 hours.

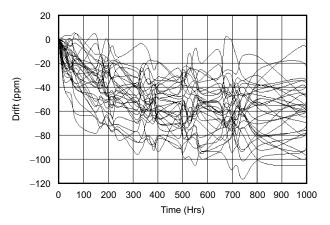


Figure 22. REF3112 Long-Term Stability

8.3.6 Load Regulation

Load regulation is defined as the change in output voltage due to changes in load current. The load regulation of the REF31xx is measured using force and sense contacts as pictured in Figure 23. The force and sense lines reduce the impact of contact and trace resistance, resulting in accurate measurement of the load regulation contributed solely by the REF31xx. For applications requiring improved load regulation, force and sense lines must be used.

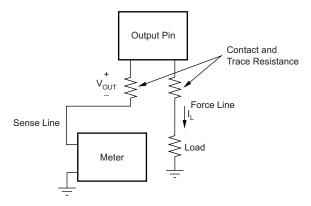


Figure 23. Accurate Load Regulation of REF31xx



8.4 Device Functional Modes

8.4.1 Negative Reference Voltage

For applications requiring a negative and positive reference voltage, the REF31xx and OPA703 can be used to provide a dual-supply reference from a ±5-V supply. Figure 24 shows the REF3125 used to provide a ±2.5-V supply reference voltage. The low drift performance of the REF31xx complement the low offset voltage and low drift of the OPA703 to provide an accurate solution for split-supply applications.

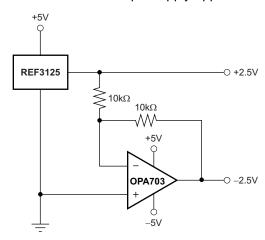


Figure 24. REF3125 Combined With OPA703 to Create Positive and Negative Reference Voltages

8.4.2 Data Acquisition

Data acquisition systems often require stable voltage references to maintain accuracy. The REF31xx family features stability and a wide range of voltages suitable for most microcontrollers and data converters. Figure 25, Figure 26, and Figure 27 show basic data acquisition systems.

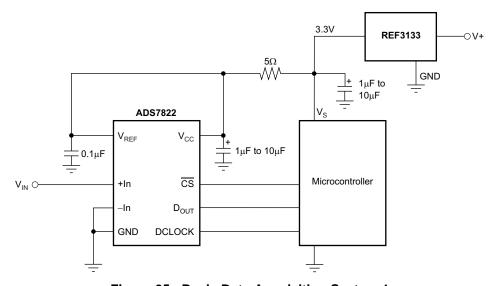


Figure 25. Basic Data Acquisition System 1



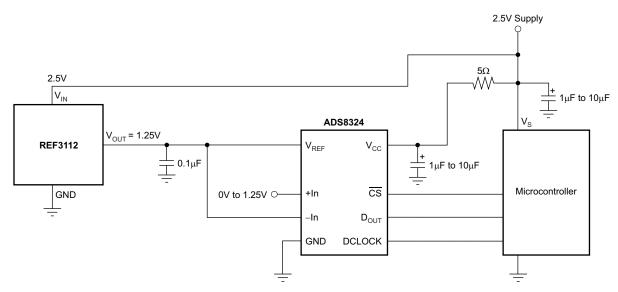


Figure 26. Basic Data Acquisition System 2

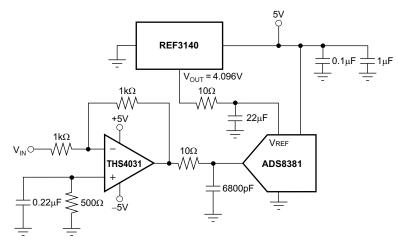


Figure 27. REF3140 Provides an Accurate Reference for Driving the ADS8381



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The REF31xx does not require a load capacitor and is stable with any capacitive load. Figure 28 shows typical connections required for operation of the REF31xx. TI recommends a supply bypass capacitor of 0.47 µF.

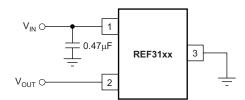


Figure 28. Typical Connections for Operating REF31xx

9.2 Typical Application

Figure 29 shows a low-power reference and conditioning circuit. This circuit attenuates and level-shifts a bipolar input voltage within the proper input range of a single-supply, low-power, 16-bit $\Delta\Sigma$ ADC, such as the one inside the MSP430 or other similar single-supply ADCs. Precision reference circuits are used to level-shift the input signal, provide the ADC reference voltage, and to create a well-regulated supply voltage for the low-power analog circuitry. A low-power, zero-drift, op-amp circuit is used to attenuate and level-shift the input signal.

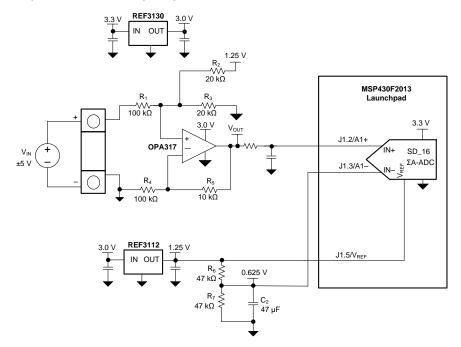


Figure 29. Low-Power Reference and Bipolar Voltage Conditioning Circuit for Low-Power ADCs



Typical Application (continued)

9.2.1 Design Requirements

Supply Voltage: 3.3 V

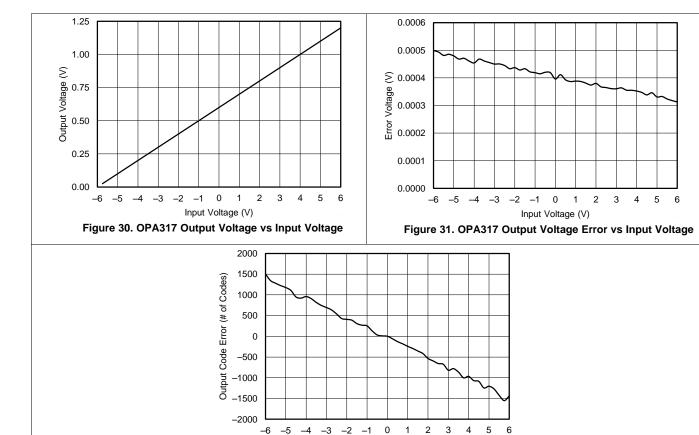
Maximum Input Voltage: ±6 V
 Specified Input Voltage: ±5 V
 ADC Reference Voltage: 1.25 V

The goal for this design is to accurately condition a ± 5 -V bipolar input voltage into a voltage suitable for conversion by a low-voltage ADC with a 1.25-V reference voltage, V_{REF} , and an input voltage range of V_{REF} / 2. The circuit should function with reduced performance over a wider input range of at least ± 6 V to allow for easier protection of overvoltage conditions.

9.2.2 Detailed Design Procedure

Figure 29 depicts a simplified schematic for this design showing the MSP430 ADC inputs and full input conditioning circuitry. The ADC is configured for a bipolar measurement where final conversion result is the differential voltage between the voltage at the positive and negative ADC inputs. The bipolar, GND-referenced input signal must be level-shifted and attenuated by the op amp so that the output is biased to VREF/2 and has a differential voltage that is within the ±VREF/2 input range of the ADC.

9.2.3 Application Curves



Input Voltage (V)
Figure 32. Output Code Error vs Input Voltage



10 Power Supply Recommendations

The REF31xx family of references features an extremely low dropout voltage. With the exception of the REF3112, which has a minimum supply requirement of 1.8 V, these references can be operated with a supply of only 5 mV above the output voltage in an unloaded condition. For loaded conditions, a typical dropout voltage versus load is shown in the front page plot, *Dropout Voltage vs Load Current*. TI recommends a supply bypass capacitor greater than $0.47~\mu F$.

11 Layout

11.1 Layout Guidelines

Figure 33 illustrates an example of a printed-circuit board (PCB) layout using the REF31xx. Some key considerations are:

- Connect low-ESR, 0.1-μF ceramic bypass capacitors at V_{IN} of the REF31xx
- Decouple other active devices in the system per the device specifications
- Use a solid ground plane to help distribute heat and reduces electromagnetic interference (EMI) noise pickup
- Place the external components as close to the device as possible. This configuration prevents parasitic errors (such as the Seebeck effect) from occurring
- Minimize trace length between the reference and bias connections to the INA and ADC to reduce noise pickup
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when absolutely necessary

11.2 Layout Example

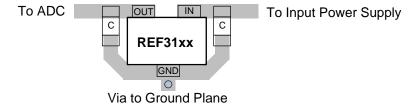


Figure 33. Layout Example



12 Device and Documentation Support

12.1 Device Support

For device support, see the following:

MSP430 MSP 16-bit and 32-bit Microcontrollers

12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
REF3112	Click here	Click here	Click here	Click here	Click here
REF3120	Click here	Click here	Click here	Click here	Click here
REF3125	Click here	Click here	Click here	Click here	Click here
REF3130	Click here	Click here	Click here	Click here	Click here
REF3133	Click here	Click here	Click here	Click here	Click here
REF3140	Click here	Click here	Click here	Click here	Click here

12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.4 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Submit Documentation Feedback

www.ti.com

23-May-2025

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
REF3112AIDBZR	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31A
REF3112AIDBZR.B	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31A
REF3112AIDBZT	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31A
REF3112AIDBZT.B	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31A
REF3120AIDBZR	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31B
REF3120AIDBZR.B	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31B
REF3120AIDBZT	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31B
REF3120AIDBZT.B	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31B
REF3125AIDBZR	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31C
REF3125AIDBZR.B	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31C
REF3125AIDBZT	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31C
REF3125AIDBZT.B	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31C
REF3130AIDBZR	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31E
REF3130AIDBZR.B	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31E
REF3130AIDBZT	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31E
REF3130AIDBZT.B	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31E
REF3133AIDBZR	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31F
REF3133AIDBZR.B	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31F
REF3133AIDBZT	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31F
REF3133AIDBZT.B	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31F
REF3140AIDBZR	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31D
REF3140AIDBZR.B	Active	Production	SOT-23 (DBZ) 3	3000 LARGE T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31D
REF3140AIDBZT	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31D
REF3140AIDBZT.B	Active	Production	SOT-23 (DBZ) 3	250 SMALL T&R	Yes	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	R31D

⁽¹⁾ Status: For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.



PACKAGE OPTION ADDENDUM

www.ti.com 23-May-2025

- (3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.
- (4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- (6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 5-Jan-2021

TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
REF3112AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3112AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3120AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3120AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3125AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3125AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3130AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3130AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3133AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3133AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3140AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3140AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3

www.ti.com 5-Jan-2021



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
REF3112AIDBZR	SOT-23	DBZ	3	3000	200.0	183.0	25.0
REF3112AIDBZT	SOT-23	DBZ	3	250	200.0	183.0	25.0
REF3120AIDBZR	SOT-23	DBZ	3	3000	200.0	183.0	25.0
REF3120AIDBZT	SOT-23	DBZ	3	250	200.0	183.0	25.0
REF3125AIDBZR	SOT-23	DBZ	3	3000	200.0	183.0	25.0
REF3125AIDBZT	SOT-23	DBZ	3	250	200.0	183.0	25.0
REF3130AIDBZR	SOT-23	DBZ	3	3000	200.0	183.0	25.0
REF3130AIDBZT	SOT-23	DBZ	3	250	200.0	183.0	25.0
REF3133AIDBZR	SOT-23	DBZ	3	3000	200.0	183.0	25.0
REF3133AIDBZT	SOT-23	DBZ	3	250	200.0	183.0	25.0
REF3140AIDBZR	SOT-23	DBZ	3	3000	200.0	183.0	25.0
REF3140AIDBZT	SOT-23	DBZ	3	250	200.0	183.0	25.0



SMALL OUTLINE TRANSISTOR



NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 This drawing is subject to change without notice.
 Reference JEDEC registration TO-236, except minimum foot length.

- 4. Support pin may differ or may not be present.
- 5. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25mm per side



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2025. Texas Instruments Incorporated